

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
		Examiner Jacob Y. Choi	Art Unit 2875	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-3,088,370	05-1963	OTTO ERBE; et. al.	359/823
*	C	US-4,519,020	05-1985	Little, William D.	362/268
*	D	US-4,151,584	04-1979	Labrum, Joseph H.	362/302
*	E	US-6,092,914	07-2000	Esakoff et al.	362/268
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	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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